EMC Test Report

Applicant	:	**Shenzhen Samkoon Technology Corporation Ltd.**
Address	:	**Building 7, Fashion Industry Park, E'Bu Town, ShenShan Special cooperation zone, Shenzhen City, Guangdong Province**
Product Name	:	**AC Servo Drives**
Report Date	:	**Jul. 07, 2023**

Hunan Anbotek Compliance Laboratory Limited

Contents

TEST REPORT

Applicant	:	Shenzhen Samkoon Technology Corporation Ltd.
Manufacturer	:	Shenzhen Samkoon Technology Corporation Ltd.
Product Name	:	AC Servo Drives
Test Model No.	:	R8-2208P-N
Reference Model No.	:	R8-22xxy-z, R8-38xxy-z Remark: xx: The output power('02' means 200W, '04' means 400W, '08' means 750W, '10' means 1000W, '15' means 1500W, '22' means 2200W, '26' means 2600W, '30' means 3000W, '40' means 4000W, '55' means 5500W, '75' means 7500W.....); y: Communication type('P' means Pulse input, 'Z' means EtherCAT, 'C' means CANopen); z: Other code('N' means standard, 'S' means Lite version, 'B' means Dynamic braking)
Trade Mark	:	Samkoon
Rating(s)	:	INPUT: 1PH, AC200-240V, 50/60Hz OUTPUT: 3PH, AC0-240V, 5.5A, 0.8kW
Test Standard(s)	:	**EN IEC 61800-3: 2018; EN IEC 61000-3-2: 2019+A1:2021; EN 61000-3-3: 2013+A1:2019+A2:2021; (IEC 61000-4-2; IEC 61000-4-3; IEC 61000-4-4; IEC 61000-4-5; IEC 61000-4-6; IEC 61000-4-11; IEC 61000-4-13)**

The device described above is tested by Hunan Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Hunan Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the EN IEC 61800-3, EN IEC 61000-3-2, EN 61000-3-3 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Hunan Anbotek Compliance Laboratory Limited.

Date of Receipt: Jun. 29, 2023

Date of Test: Jun. 29~Jul. 05, 2023

Prepared By: Qing Peng

(Qing Peng)

Approved & Authorized Signer: Andy Wang

(Andy Wang)

1. General Information

1.1. Client Information

Applicant	:	Shenzhen Samkoon Technology Corporation Ltd.
Address	:	Building 7, Fashion Industry Park, E'Bu Town, ShenShan Special cooperation zone, Shenzhen City, Guangdong Province
Manufacturer	:	Shenzhen Samkoon Technology Corporation Ltd.
Address	:	Building 7, Fashion Industry Park, E'Bu Town, ShenShan Special cooperation zone, Shenzhen City, Guangdong Province
Factory	:	Shenzhen Samkoon Technology Corporation Ltd.
Address	:	Building 7, Fashion Industry Park, E'Bu Town, ShenShan Special cooperation zone, Shenzhen City, Guangdong Province

1.2. Description of Device (EUT)

Product Name	:	AC Servo Drives
Test Model No.	:	R8-2208P-N
Reference Model No.	:	R8-22xxy-z, R8-38xxy-z Remark: xx: The output power('02' means 200W, '04' means 400W, '08' means 750W, '10' means 1000W, '15' means 1500W, '22' means 2200W, '26' means 2600W, '30' means 3000W, '40' means 4000W, '55' means 5500W, '75' means 7500W.....); y: Communication type('P' means Pulse input, 'Z' means EtherCAT, 'C' means CANopen); z: Other code('N' means standard, 'S' means Lite version, 'B' means Dynamic braking) (Note: All samples are the same except the model number & appearance, so we prepare "R8-2208P-N" for test only.)
Trade Mark	:	Samkoon
Test Power Supply	:	AC 230V, 50Hz
Test Sample No.	:	1-1-1
Product Description	:	N/A
Remark: (1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.		

Address:101, Building 37, Liandong Yougu Industrial Park, No.32,Yulian Road, Xueshi Street, Yuelu District, Changsha, Hunan, China
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Hotline 400-003-0500
www.anbotek.com.cn

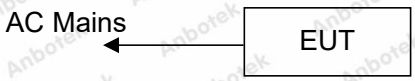
1.3. Auxiliary Equipment Used During Test

N/A		

1.4. Description of Test Mode

Pretest Mode	Description
Mode 1	Working

For Mode 1 Block Diagram of Test Setup



1.5. Test Summary

Test Items	Test Mode	Status
Power Line Conducted Emission Test	Mode 1	P
Asymmetric Mode Conducted Emission at Telecom Port	/	N
Radiated Emission Test (Below 1 GHz)	Mode 1	P
Radiated Emission Test (Above 1GHz)	/	N
Harmonic Current Test	Mode 1	P
Voltage Fluctuations & Flicker Test	Mode 1	P
Electrostatic Discharge Immunity Test	Mode 1	P
RF Field Strength Immunity Test	Mode 1	P
Electrical Fast Transient/Burst Immunity Test	Mode 1	P
Surge Immunity Test	Mode 1	P
Injected Currents Susceptibility Test	Mode 1	P
Power frequency Magnetic Field Immunity Test	/	N
Voltage Dips and Interruptions Immunity Test	/	N
P) Indicates “PASS”. F) Indicates “Fail”. N) Indicates “Not applicable”.		

1.6. Test Equipment List

☒ Power Line Conducted Emission Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Oct. 23, 2022	1 Year
2.	Three Phase V-type Artificial Power Network	CYBERTEK	EM5040DT	E215040DT001	Jul. 05, 2023	1 Year
3.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Oct. 13, 2022	1 Year
4.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Oct. 22, 2022	1 Year
5.	Software Name EZ-EMC	Ferrari Technology	ANB-03A	N/A	N/A	N/A

☐ Asymmetric Mode Conducted Emission at Telecom Port

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	ISN	Schwarzbeck	NTFM 8158	#172	Oct. 13, 2022	1 Year
2.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Oct. 13, 2022	1 Year
3.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Oct. 22, 2022	1 Year
4.	Software Name EZ-EMC	Ferrari Technology	ANB-03A	N/A	N/A	N/A
5.	Three Phase V-type Artificial Power Network	CYBERTEK	EM5040DT	E215040DT001	Jul. 05, 2022	1 Year

☒ Radiated Emission Test (Below 1 GHz)

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Oct. 13, 2022	1 Year
2.	Pre-amplifier	Schwarzbeck	BBV-9745	9745-075	Oct. 23, 2022	1 Year
3.	Bilog Broadband Antenna	SCHWARZBECK	VULB 9163	01109	Oct. 16, 2022	3 Year
4.	Software Name EZ-EMC	Ferrari Technology	EMEC-3A1	N/A	N/A	N/A

☐ Radiated Emission Test (Above 1GHz)

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	EMI Test Receiver	Rohde & Schwarz	ESR26	101481	Oct. 23, 2022	1 Year
2.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Oct. 23, 2022	1 Year
3.	Pre-amplifier	SONOMA	310N	186860	Oct. 23, 2022	1 Year
4.	Software Name EZ-EMC	Ferrari Technology	ANB-03A	N/A	N/A	N/A
5.	EMI Preamplifier	SKET Electronic	LNPA-0118G-45	SKET-PA-002	Oct. 13, 2022	1 Year
6.	Double Ridged Horn Antenna	SCHWARZBECK	BBHA 9120D	02555	Oct. 16, 2022	3 Year

☒ Harmonic Current and Flicker Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Programmable AC Power source	IVYTECH	APS-5005A	632734	Oct. 23, 2022	1 Year
2.	Harmonic and Flicker Analyzer	EMC-PARTNER	HMONICS 1000-1P	164	Oct. 23, 2022	1 Year
3.	Harmonics-1000	N/A	Ed.3.0+4.0	N.A	N/A	N/A

☒ Electrostatic Discharge Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	ESD Simulators	emtest	ESD NX30.1	11936	Mar. 17, 2023	1 Year

☒ RF Field Strength Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Signal Generator	Agilent	N5181A	MY50143107	Apr. 20, 2023	1 Year
2.	Power Meter	Agilent	E4417A	MY45101384	Apr. 20, 2023	1 Year
3.	Amplifier	Micotop	MPA-80-1000-600	MPA2110318	Apr. 20, 2023	1 Year
4.	Amplifier	Micotop	MPA-1000-6000-100	MPA2110327	Apr. 20, 2023	1 Year
5.	Log.-Per.-Antenna	Schwarzbeck	VULP 9118E	01012	N/A	N/A
6.	Microwave Log.-Per. Antenna	Schwarzbeck	STLP 9149	00788	N/A	N/A
7.	Power Sensor	KEYSIGHT	E9323A	US40410647	Apr. 20, 2023	1 Year
8.	Power Sensor	KEYSIGHT	E9323A	MY53100007	Apr. 20, 2023	1 Year
9.	Electric field Probe	Narda S.T.S /PMM	EP 601	811ZX10351	Apr. 20, 2023	1 Year
10.	Software	EMtrace	EM 3	/	N/A	N/A

☒ Electrical Fast Transient/Burst Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Surge Generator	TESEQ	NSG 3060	1480	Oct. 23, 2022	1 Year
2.	CDN	TESEQ	CDN 3061	1408	Oct. 23, 2022	1 Year
3.	EFT-Clamp	PRIMA	EFT-Clamp	/	Oct. 13, 2022	1 Year

☒ Surge Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Combined Wave Lightning Surge Simulator	3Ctest	CCS600	ES3771702	Jul. 05, 2023	1 Year
2.	Three Phase Power Coupling Network	3Ctest	SEPN69100T	ES0801757	Jul. 05, 2023	1 Year
3.	Telecom port surge generator	PMI	TW101	190411	Apr. 20, 2023	1 Year

☒ Injected Currents Susceptibility Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	C/S Conducted Immunity Test System	FRANKONIA	CIT-10	126A1196/2012	Oct. 23, 2022	1 Year
2.	CDN	FRANKONIA	CDN - M2+ M3	A2210178/2012	Oct. 23, 2022	1 Year
3.	6dB Attenuator	FRANKONIA	DAM 26W	1172202	Oct. 23, 2022	1 Year
4.	CIT-10	FRANKONIA	Version1.1.7	N/A	N/A	N/A
5.	EM-Clamp	FRANKONIA	EMCL-20	18101728-0103	Apr. 20, 2023	1 Year

☐ Power frequency Magnetic Field Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Power Frequency Magnetic Field Generator	EVERFINE	EMS61000-8K	906002	Oct. 23, 2022	1 Year

☐ Voltage Dips and Interruptions Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	CYCLE SAG Simulator	PRIMA	DRP61011AG	PR12046234	Oct. 23, 2022	1 Year

1.7. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

Test Location

Hunan Anbotek Compliance Laboratory Limited.

Building 37, Liandong Yougu Industrial Park, No.32, Yulian Road, Xueshi Street, Yuelu District, Changsha, Hunan,China

1.8. EMS Performance Criteria

Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion B

During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test.

After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed.

Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

2. Power Line Conducted Emission Test

2.1. Test Standard and Limit

Test Standard:	EN IEC 61800-3

☐ **Limits for conducted emissions (Category C1)**

Frequency (MHz)	Limits (dBμV)	
	Quasi-peak Level	Average Level
0.15 ~ 0.50	66.0 ~ 56.0 *	56.0 ~ 46.0 *
0.50 ~ 5.00	56.0	46.0
5.00 ~ 30.00	60.0	50.0
Remark: The lower limit shall apply at the transition frequencies.		

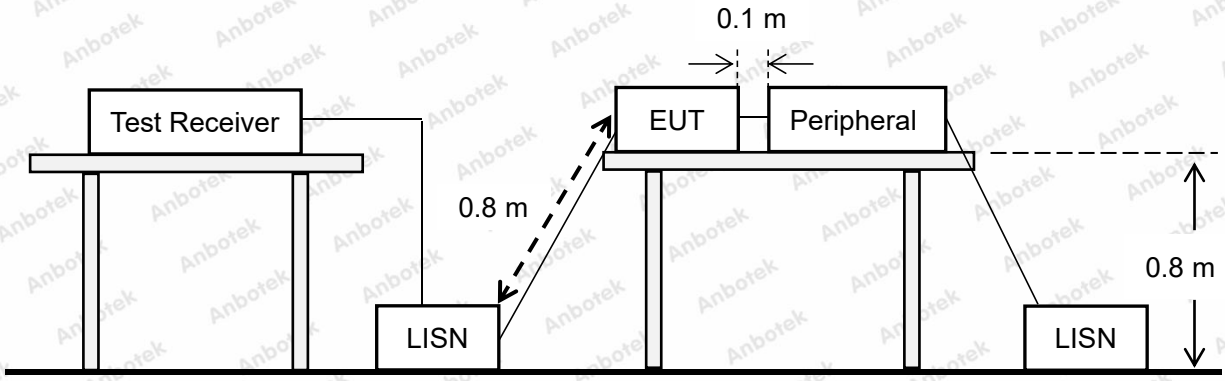
☒ **Limits for conducted emissions (Category C2)**

Frequency (MHz)	Limits (dBμV)	
	Quasi-peak Level	Average Level
0.15 ~ 0.50	79.0	66.0
0.50 ~ 5.00	73.0	60.0
5.00 ~ 30.00	73.0	60.0
Remark: (1) The lower limit shall apply at the transition frequencies. (2) The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.		

☐ **Limits for conducted emissions (Category C3)**

Frequency (MHz)	Limits (dBμV)			
	I≤100A		100A<I	
	Quasi-peak Level	Average Level	Quasi-peak Level	Average Level
0.15 ~ 0.50	100.0	90.0	130.0	120.0
0.50 ~ 5.00	86.0	76.0	125.0	115.0
5.00 ~ 30.00	90.0 ~ 73.0 *	80.0 ~ 60.0 *	115.0	105.0
Remark: (1) The lower limit shall apply at the transition frequencies. (2) The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.				

2.2. Test Setup



2.3. Test Procedure

The table-top EUT is placed on a non-conductive table 0.8 m above the horizontal ground reference plane, and the back of the EUT is 0.4 m away from the vertical ground reference plane, and at least 0.8 m from any other metal surface or ground plane. The floor-standing EUT is placed on an insulating support 0.1 m above the horizontal ground reference plate, at least 0.8 m away from other metal objects.

Connect EUT to the power mains through an LISN. Where the mains cable supplied by the manufacturer is longer than 1 m, the excess should be folded at the center into a bundle no longer than 0.4 m, so that its length is shortened to 1 m. All the peripherals are connecting to the other LISN.

The initial testing identified the frequency that has the highest disturbance relative to the limit while operating the EUT in typical modes of operation and cable positions in a test setup representative of typical system configuration.

The identification of the frequency of highest disturbance with respect to the limit was found by investigating disturbances at a number of significant frequencies. The probable frequency of maximum disturbance had been found and that the associated cable and EUT configuration and mode of operation had been identified.

Set the test-receiver to quasi peak detect function and average detect function, and to measure the conducted emissions values.

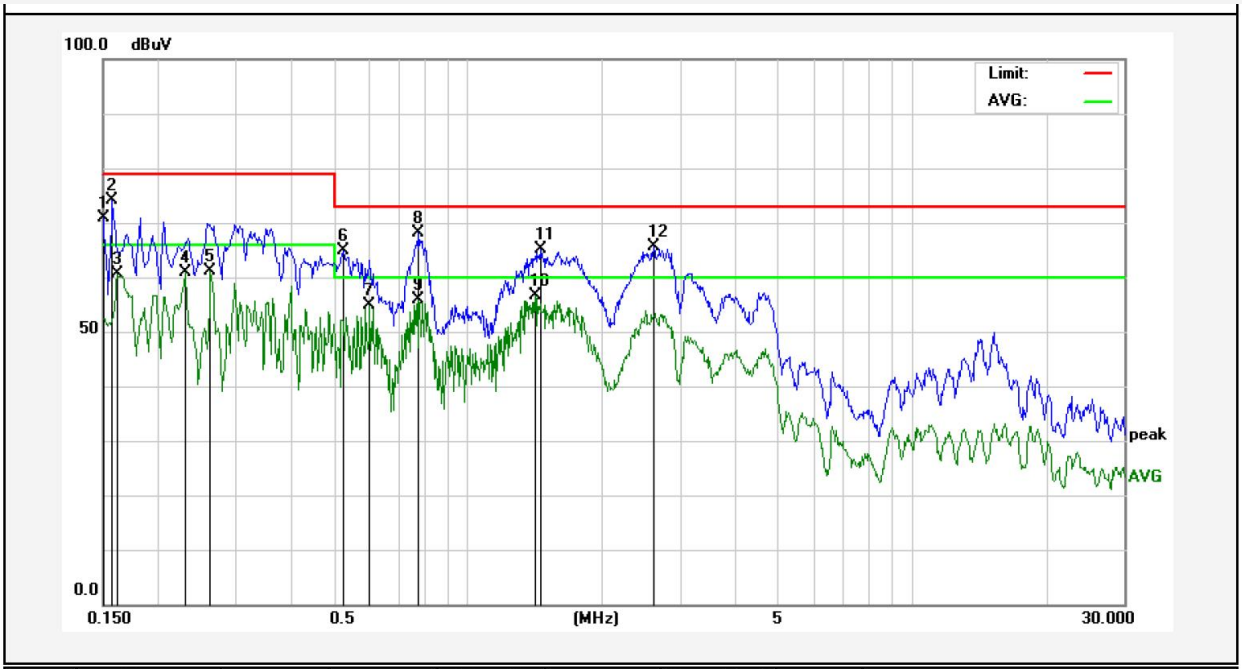
2.4. Test Results

PASS

The test curves are shown in the following pages.

Power Line Conducted Test Data

Test Site: 1# Shielded Room
Test Specification: AC 230V, 50Hz
Comment: Live Line
Temp.: 24.3℃ Hum.: 61%

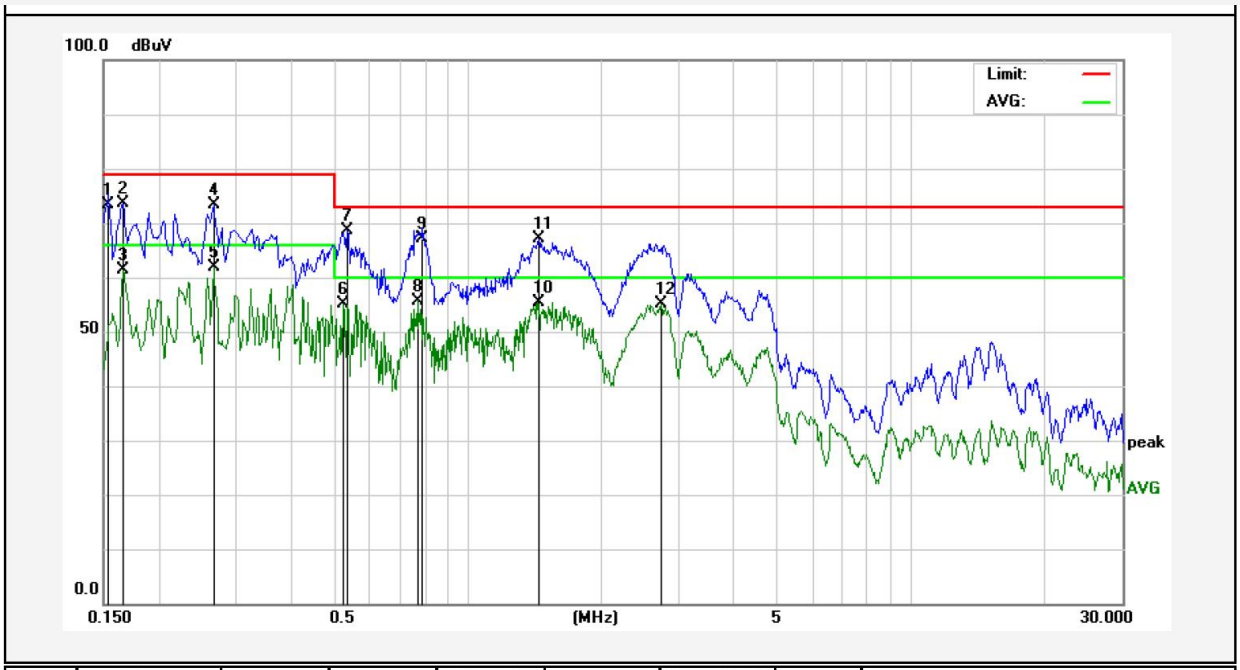


No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Over Limit (dB)	Detector	Remark
1	0.1499	51.12	19.82	70.94	79.00	-8.06	QP	
2	0.1580	54.24	19.83	74.07	79.00	-4.93	QP	
3	0.1620	40.78	19.83	60.61	66.00	-5.39	AVG	
4	0.2300	41.05	19.82	60.87	66.00	-5.13	AVG	
5	0.2620	41.37	19.84	61.21	66.00	-4.79	AVG	
6	0.5220	45.01	19.86	64.87	73.00	-8.13	QP	
7	0.5978	34.92	19.86	54.78	60.00	-5.22	AVG	
8	0.7740	48.25	19.87	68.12	73.00	-4.88	QP	
9	0.7740	36.09	19.87	55.96	60.00	-4.04	AVG	
10	1.4178	36.77	19.86	56.63	60.00	-3.37	AVG	
11	1.4497	45.32	19.86	65.18	73.00	-7.82	QP	
12	2.6179	45.67	19.85	65.52	73.00	-7.48	QP	

Note: Result = Reading + Factor Over Limit = Result - Limit

Power Line Conducted Test Data

Test Site: 1# Shielded Room
Test Specification: AC 230V, 50Hz
Comment: Neutral Line
Temp.: 24.3℃ Hum.: 61%



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Over Limit (dB)	Detector	Remark
1	0.1539	53.54	19.83	73.37	79.00	-5.63	QP	
2	0.1660	53.81	19.83	73.64	79.00	-5.36	QP	
3	0.1660	41.55	19.83	61.38	66.00	-4.62	AVG	
4	0.2660	53.54	19.84	73.38	79.00	-5.62	QP	
5	0.2660	42.15	19.84	61.99	66.00	-4.01	AVG	
6	0.5220	35.16	19.86	55.02	60.00	-4.98	AVG	
7	0.5340	48.67	19.86	68.53	73.00	-4.47	QP	
8	0.7700	35.88	19.87	55.75	60.00	-4.25	AVG	
9	0.7900	47.37	19.87	67.24	73.00	-5.76	QP	
10	1.4337	35.62	19.86	55.48	60.00	-4.52	AVG	
11	1.4457	47.27	19.86	67.13	73.00	-5.87	QP	
12	2.7219	35.29	19.85	55.14	60.00	-4.86	AVG	

Note: Result = Reading + Factor Over Limit = Result - Limit

3. Radiated Emission Test (Below 1 GHz)

3.1. Test Standard and Limit

Test Standard	EN IEC 61800-3

☐ **Radiated Emission Test Limit (Category C1)**

Frequency (MHz)	Distance (Meters)	Field Strengths Limit (dBμV/m)
30 ~ 230	3	40
230 ~ 1000	3	47
Remark: The lower limit shall apply at the transition frequencies.		

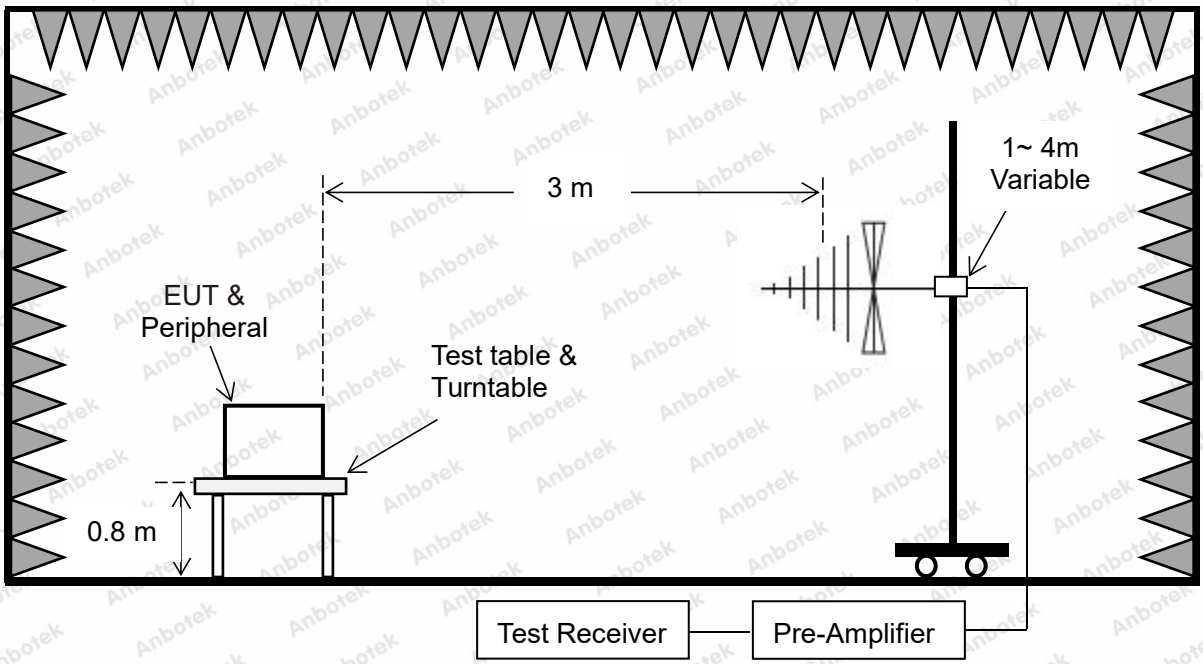
☒ **Radiated Emission Test Limit (Category C2)**

Frequency (MHz)	Distance (Meters)	Field Strengths Limit (dBμV/m)
30 ~ 230	3	50
230 ~ 1000	3	57
Remark: The lower limit shall apply at the transition frequencies.		

☐ **Radiated Emission Test Limit (Category C3)**

Frequency (MHz)	Distance (Meters)	Field Strengths Limit (dBμV/m)
30 ~ 230	3	60
230 ~ 1000	3	70
Remark: The lower limit shall apply at the transition frequencies.		

3.2. Test Setup



3.3. Test Procedure

The table-top EUT is placed on a non-conductive table 0.8 m above the horizontal ground reference plane. The floor-standing EUT is placed on an insulating support 0.1 m above the horizontal ground reference plane.

The EUT was set 3 m away from the receiving antenna that was mounted on a non-conductive mast. The antenna can move up and down between 1 to 4 m to find out the maximum emission level.

The turntable can rotate 360 degree to determine the position of the maximum emission level.

The initial testing identified the frequency that has the highest disturbance relative to the limit while operating the EUT in typical modes of operation and cable positions in a test setup representative of typical system configuration.

The identification of the frequency of highest emission with respect to the limit was found by investigating emissions at a number of significant frequencies. The probable frequency of maximum emission had been found and that the associated cable and EUT configuration and mode of operation had been identified.

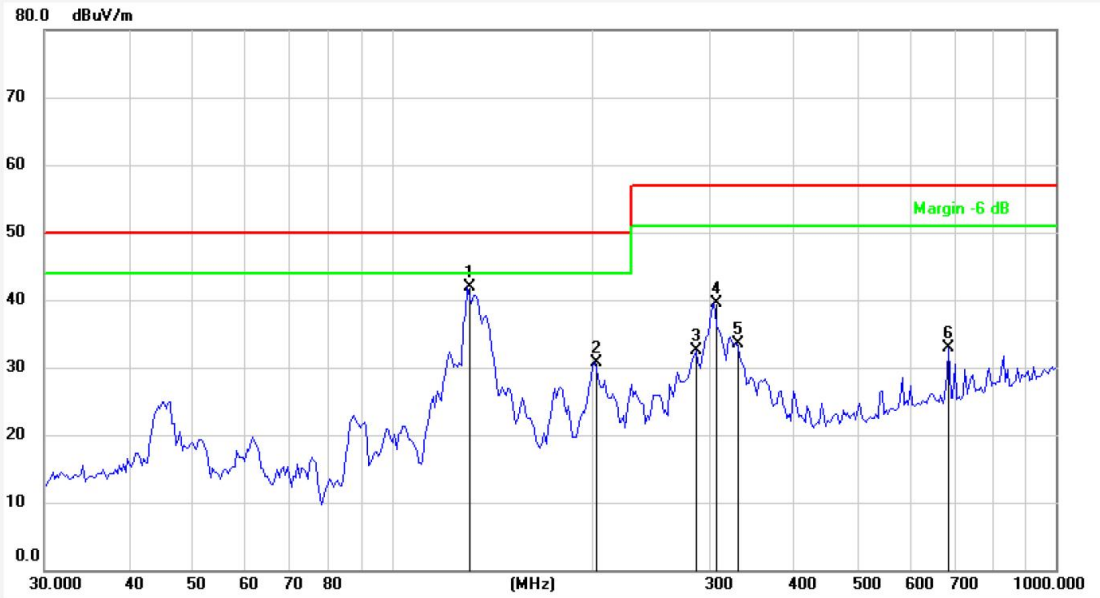
The bandwidth of the Receiver is set at 120 kHz.

3.4. Test Results

PASS

The test curves are shown in the following pages.

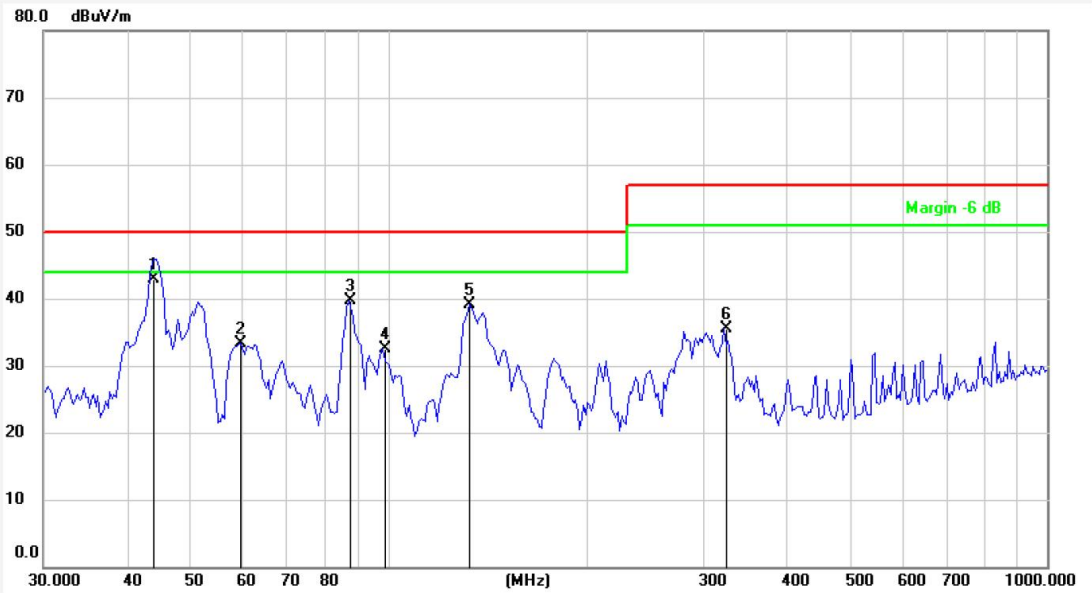
Test item:	Radiation Test	Polarization:	Horizontal
Standard:	(RE)EN IEC 61800-3	Power Source:	AC 230V, 50Hz
Frequency Range:	30MHz ~ 1000MHz	Temp.(℃)/Hum.(%RH):	24.5(℃)/56%RH
Distance:	3m		



No.	Freq. (MHz)	Reading (dBuV)	Factor ()	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	129.9226	62.76	-20.80	41.96	50.00	-8.04	QP			
2	202.1005	48.79	-18.09	30.70	50.00	-19.30	QP			
3	286.9823	47.65	-15.16	32.49	57.00	-24.51	QP			
4	305.6800	54.25	-14.71	39.54	57.00	-17.46	QP			
5	330.1949	47.53	-14.12	33.41	57.00	-23.59	QP			
6	689.5644	40.31	-7.49	32.82	57.00	-24.18	QP			

Note: Result= Reading + Factor Over Limit=Result-Limit

Test item:	Radiation Test	Polarization:	Vertical
Standard:	(RE)EN IEC 61800-3	Power Source:	AC 230V, 50Hz
Frequency Range:	30MHz ~ 1000MHz	Temp.(℃)/Hum.(%RH):	24.5(℃)/56%RH
Distance:	3m		



No.	Freq. (MHz)	Reading (dBuV)	Factor ()	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	44.1202	59.95	-16.98	42.97	50.00	-7.03	QP			
2	59.6493	51.02	-17.68	33.34	50.00	-16.66	QP			
3	87.1117	58.97	-19.29	39.68	50.00	-10.32	QP			
4	98.1419	49.63	-17.20	32.43	50.00	-17.57	QP			
5	132.6850	60.01	-20.96	39.05	50.00	-10.95	QP			
6	323.3204	49.72	-14.28	35.44	57.00	-21.56	QP			

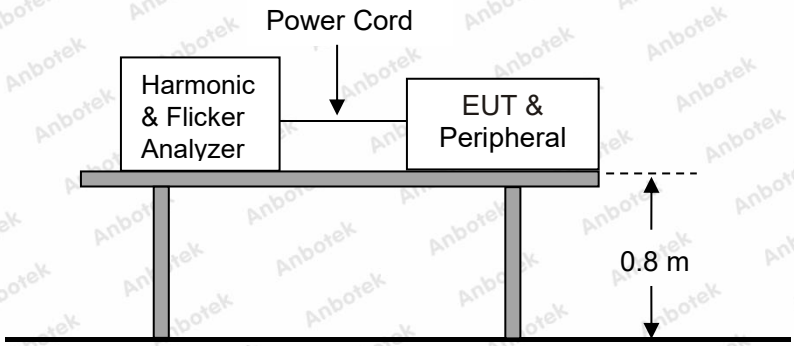
Note: Result= Reading + Factor Over Limit=Result-Limit

4. Harmonic Current Test

4.1. Test Standard

Test Standard:	EN IEC 61000-3-2

4.2. Test Setup



4.3. Test Procedure

The table-top EUT is placed on the top of a wooden table 0.8 m above the ground (0.1 m for the floor-standing EUT) and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the necessary for the EUT to be exercised.

4.4. Test Results

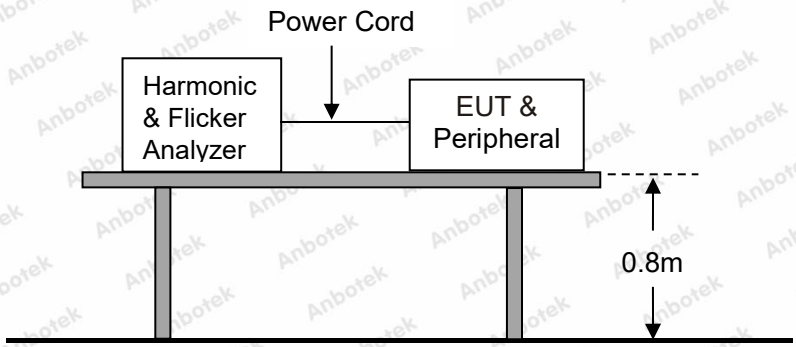
The active input power of the EUT is less than 75W. Therefore, according to EN IEC 61000-3-2, no limits are necessary.

5. Voltage Fluctuations & Flicker Test

5.1. Test Standard

Test Standard:	EN 61000-3-3

5.2. Test Setup



5.3. Test Procedure

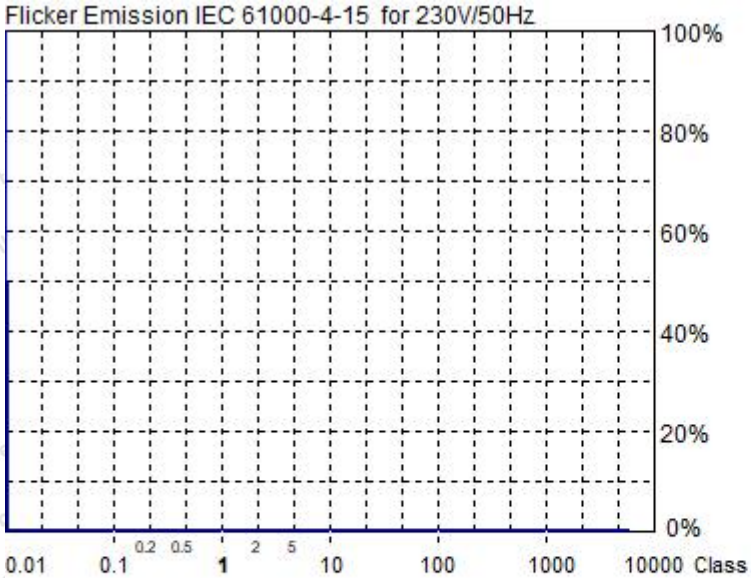
The table-top EUT is placed on the top of a wooden table 0.8 m above the ground (0.1 m for the floor-standing EUT) and operated to produce the most unfavorable sequence of voltage changes under normal conditions during the flicker measurement. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

5.4. Test Results

PASS

The test curves are shown in the following pages.

Flicker Test Summary (Run time)



Actual Flicker (Fli):	**0.00**
Short-term Flicker (Pst):	**0.07**
Limit (Pst):	1.00
Long-term Flicker (Plt):	**0.00**
Limit (Plt):	0.65
Maximum Relative Volt. Change (dmax):	**0.00%**
Limit (dmax):	4.00%
Relative Steady-state Voltage Change (dc):	**0.03%**
Limit (dc):	3.30%
Tmax 3.30% (dt):	**0.00ms**
Limit (dt>Lim):	500ms

Flicker Emission - IEC 61000-3-3 , EN 61000-3-3

2023/7/4 17:53:25 hf.hsu

Urms =	229.5	V	P =	4.467	W
Irms =	0.049	A	pf =	0.397	

Range: 0.5 A
V-nom: 230 V
TestTime: 10 min (1%)

18240EC300275

Test aborted, Result: PASSED

HAR-1000 EMC-Partner

Full Bar : Actual Values
Empty Bar : Maximum Values
Circles : Average Values
Blue : Current , Green : Voltage , Red : Failed

Urms =	**229.5V**	**Freq =**	**50.000**	**Range:**	**0.5 A**
Irms =	**0.049A**	**Ipk =**	**0.281A**	**cf =**	**5.731**
P =	**4.467W**	**S =**	**11.26VA**	**pf =**	**0.397**

Test - Time : 10 x 1min = 10min (100 %)

LIN (Line Impedance Network) : No LIN

Limits :	**Plt :**	**0.65**	**Pst :**	**1.00**	
		dmax :	**4.00 %**	**dc :**	**3.30 %**
		dtLim:	**3.30 %**	**dt>Lim:**	**500ms**

Test aborted, Result: PASSED

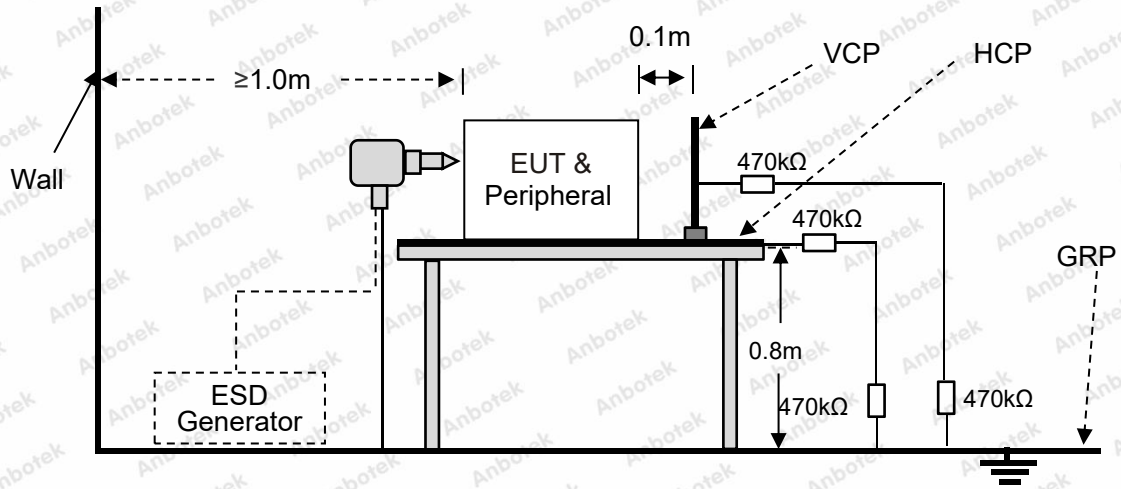
	dmax [%]	dc [%]	dt>Lim [ms]
1	0.000	0.000	0.000

6. Electrostatic Discharge Immunity Test

6.1. Test Specification

Test Standard :	EN IEC 61800-3	
Basic standard :	IEC 61000-4-2: 2008	
Performance criteria:	B	
Test Level :	± 8kV (Air Discharge)	± 4kV (Contact Discharge)

6.2. Test Setup



6.3. Test Procedure

a. In the case of air discharge testing, the climatic conditions shall be within the following ranges:
- Ambient temperature: 15°C to 35°C;
- Relative humidity: 30% to 60%;
- Atmospheric pressure: 86 kPa (860 mbar) to 106 kPa (1060 mbar)

b. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

c. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted: - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate. - Coating declared as insulating by the manufacturer shall only be submitted to the air discharge. - The contact discharge test shall not be applied to such surfaces.

d. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.

e. The test voltage shall be increased from the minimum to the selected test severity level, in order to determine any threshold of failure. The final test level should not exceed the product specification value in order to avoid damage to the equipment.

f. The test shall be performed with both air discharge and contact discharge. The test shall be performed with single discharges. On each pre-selected point at least 10 single discharges (in the most sensitive polarity) shall be applied. For the time interval between successive single discharges an initial value of 1 s is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.

g. Ensure that the applied charge on the EUT has been dis-charged before next ESD pulse.

6.4. Test Results

PASS

Please refer to the following page.

Electrostatic Discharge Test Results

Test Result:	☒ Pass ☐ Fail	Temperature:	22.6℃
Power Supply:	AC 230V, 50Hz	Humidity:	41%

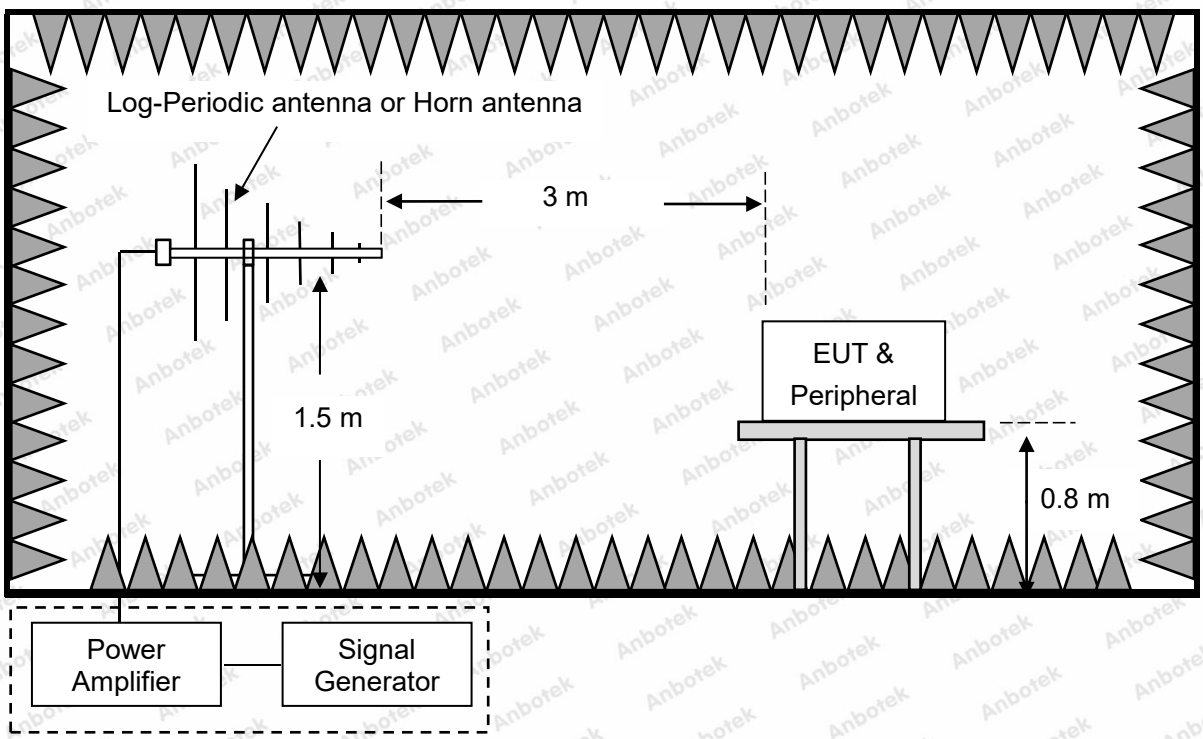
Location		Kind A-Air Discharge C-Contact Discharge	Result
Air discharge: ±8.0 kV		Contact discharge: ±4.0 kV	
Slot	4 points	A	☒A ☐B ☐C
Metal	4 points	C	☒A ☐B ☐C
Screw	4 points	C	☒A ☐B ☐C
Screen	4 points	A	☒A ☐B ☐C
HCP	4 points	C	☒A ☐B ☐C
VCP of the front	4 points	C	☒A ☐B ☐C
VCP of the rear	4 points	C	☒A ☐B ☐C
VCP of the left	4 points	C	☒A ☐B ☐C
VCP of the right	4 points	C	☒A ☐B ☐C
Note: N/A			

7. RF Field Strength Immunity Test

7.1. Test Specification

Test Standard:	EN IEC 61800-3		
Basic standard:	IEC 61000-4-3: 2006		
Performance criteria:	A	A	A
Frequency Range:	☒ 80MHz to 1000MHz	☒ 1.4GHz to 2.0GHz	☒ 2.0GHz to 2.7GHz
Test level:	☒ 10V/m ☐ 3 V/m	3 V/m	1 V/m
Modulation:	1kHz Sine Wave, 80%, AM Modulation		
Frequency Step:	1 % of preceding frequency value		
Polarity of Antenna:	Horizontal and Vertical		
Test Distance:	3 m		
Antenna Height:	1.5 m		
Dwell Time:	at least 0.5s		

7.2. Test Setup



7.3. Test Procedure

The procedure defined in this part requires the generation of electromagnetic fields within which the test sample is placed and its operation observed. To generate fields that are useful for simulation of actual (field) conditions may require significant antenna drive power and the resultant high field strength levels. To comply with local regulations and to prevent biological hazards to the testing personnel, it is recommended that these tests be carried out in a shielded enclosure or semi-anechoic chamber.

a. The antenna is placed 3 m from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the antenna.

b. The test shall normally be performed with the generating antenna facing each side of the EUT. When equipment can be used in different orientations (i.e. vertical or horizontal) all sides shall be exposed to the field during the test. When technically justified, some EUTs can be tested by exposing fewer faces to the generating antenna. In other cases, as determined for example by the type and size of EUT or the frequencies of test, more than four azimuths may need to be exposed.

c. The polarization of the field generated by each antenna necessitates testing each selected side twice, once with the antenna positioned vertically and again with the antenna positioned horizontally.

d. The step size of the frequency is set to 1%. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised and to be able to respond. However, the dwell time should not exceed 5 s at each of the frequencies during the scan.

7.4. Test Results

PASS

Please refer to the following page.

RF Field Strength Susceptibility Test Results

Test Result:	☒ Pass ☐ Fail	Temperature:	22.4℃
Power Supply:	AC 230V, 50Hz	Humidity:	53%

Frequency Range	Antenna Polarity	R.F. Field Strength	Dwell Time	Azimuth	Result
80 MHz ~ 1000 MHz	H / V	☒ 10 V/m ☐ 3 V/m	1s	Front Rear Left Right	☒ A ☐ B ☐ C
1.4GHz ~ 2GHz	H / V	3 V/m	1s	Front Rear Left Right	☒ A ☐ B ☐ C
2GHz ~ 2.7GHz	H / V	1 V/m	1s	Front Rear Left Right	☒ A ☐ B ☐ C

Note: N/A

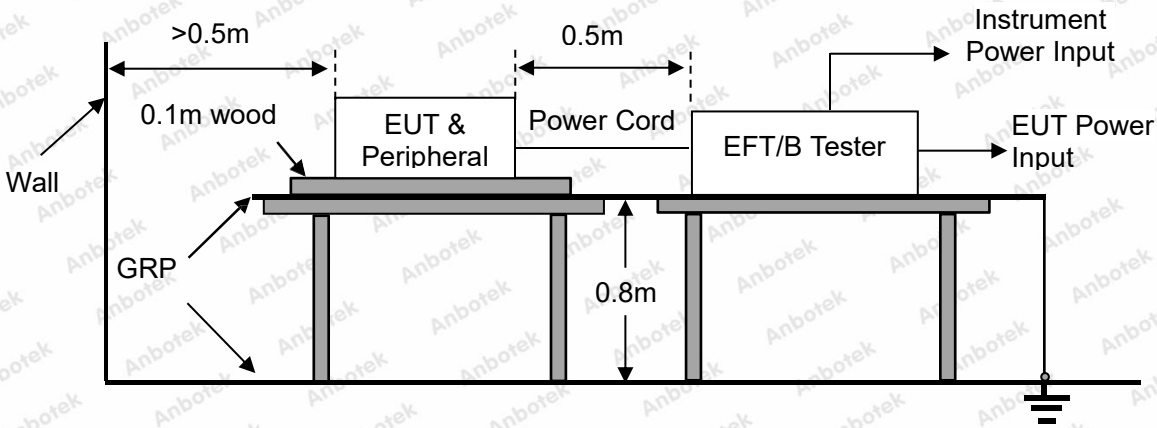
8. Electrical Fast Transient/Burst Immunity Test

8.1. Test Specification

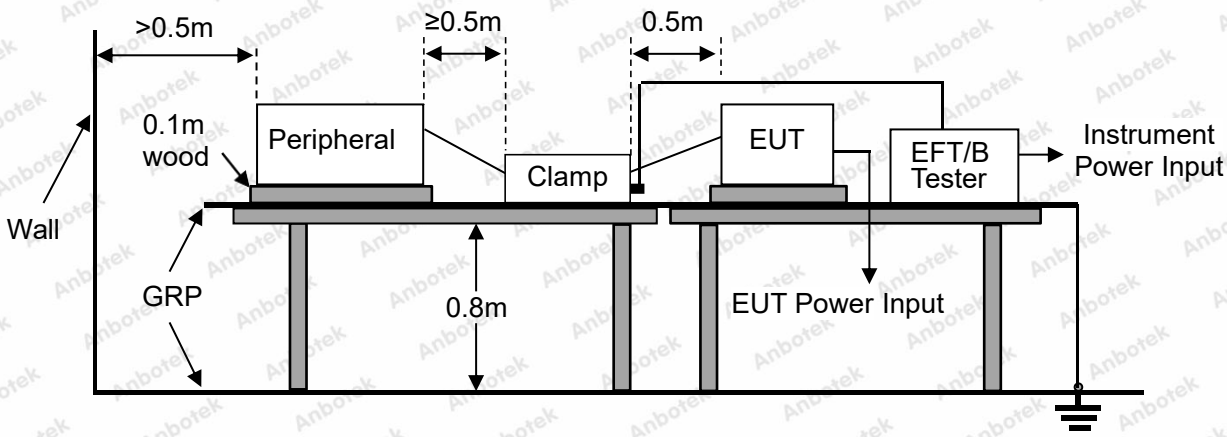
Test Standard:	EN IEC 61800-3
Basic standard:	IEC 61000-4-4: 2012
Performance criterion:	B
Test Level:	☒ 2 kV, AC mains power ports

8.2. Test Setup

AC mains power ports and DC network power ports:



Analogue/digital data ports:



8.3. Test Procedure

The table-top EUT is placed on a table that is 0.8 m height, a ground reference plane is placed on the

table, and uses 0.1 m insulation between the EUT and ground reference plane. The floor-standing EUT is placed on a ground reference plane and insulated from it by an insulating support with a thickness of 0.1 m. This reference ground plane shall project beyond the EUT by at least 0.1 m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5 m.

All cables to the EUT shall be placed on the insulation support 0.1 m above the ground reference plane. Cables not subject to electrical fast transients shall be routed as far as possible from the cable under test to minimize the coupling between the cables.

8.4. Test Results

PASS

Please refer to the following page.

Electrical Fast Transient/Burst Test Results

Test Result:	☒ Pass ☐ Fail	Temperature:	23.6℃
Power Supply:	AC 230V, 50Hz	Humidity:	56%

Ports	Polarity	Inject Time(s)	Test Voltage (kV)	Result
AC mains power ports	±	120 s	2.0 kV	☒A ☐B ☐C

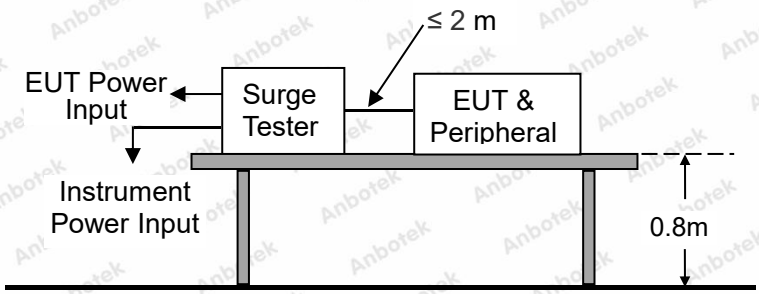
Note: N/A

9. Surge Immunity Test

9.1. Test Specification

Test Standard:		EN IEC 61800-3
Basic standard:		IEC 61000-4-5:2014
Performance criterion:		B
Test level	AC power port:	☒ 1 kV, Line to Line, Criterion B
		☒ 2kV, Line to Ground, Criterion B
Number of surges		5 (for each combination of parameters)
Repetition rate		1 minute / time
Polarity:		Positive / Negative
Phase angle:		0°, 90°, 180°, 270° (Only AC mains power ports)

9.2. Test Setup



9.3. Test Procedure

Table-top EUT is placed on a table of 0.8 m heights above a metal ground reference plane. Floor standing EUT is placed on a ground reference plane and insulated from it by an insulating support with a thickness of 0.1 m. The length of the power cord between the EUT and the coupling/decoupling network is not more than 2 m, and the length of the interconnection line between the EUT and the coupling/decoupling network is not more than 2 m. The tests were done at repetition rate 1 per minute.

9.4. Test Results

PASS

Please refer to the following page.

Surge Immunity Test Results

Humidity :	56%		Temperature :		23.6℃
Power Supply :	AC 230V, 50Hz		Criterion required:		A
Test Result :	☒ Pass ☐ Fail				
Location	Polarity	Phase Angle	Number of Pulse	Pulse Voltage (kV)	Performance Criterion
☒ AC power port (Waveform: 1.2 us / 50 us (8 us / 20us))					
L-N	+	☒ 0° ☒ 90° ☒ 180° ☒ 270°	5	1.0kV	☒A ☐B ☐C
	-	☒ 0° ☒ 90° ☒ 180° ☒ 270°	5	1.0kV	☒A ☐B ☐C
L-PE	+	☒ 0° ☒ 90° ☒ 180° ☒ 270°	5	2.0kV	☒A ☐B ☐C
	-	☒ 0° ☒ 90° ☒ 180° ☒ 270°	5	2.0kV	☒A ☐B ☐C
N-PE	+	☒ 0° ☒ 90° ☒ 180° ☒ 270°	5	2.0kV	☒A ☐B ☐C
	-	☒ 0° ☒ 90° ☒ 180° ☒ 270°	5	2.0kV	☒A ☐B ☐C

10. Injected Currents Susceptibility Test

10.1. Test Specification

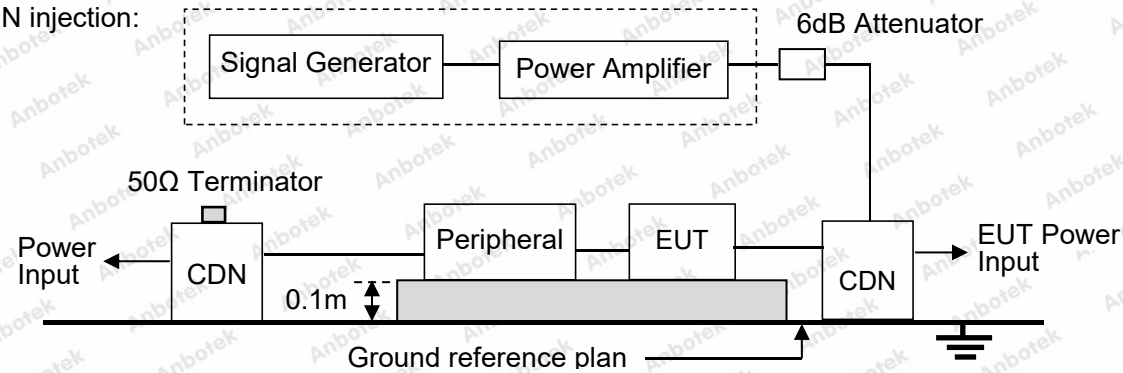
Test Standard	EN IEC 61800-3
Basic standard:	IEC 61000-4-6:2013
Performance criterion	A
Severity Level 3: 10V (rms), (0.15MHz ~80MHz)	

Test Level

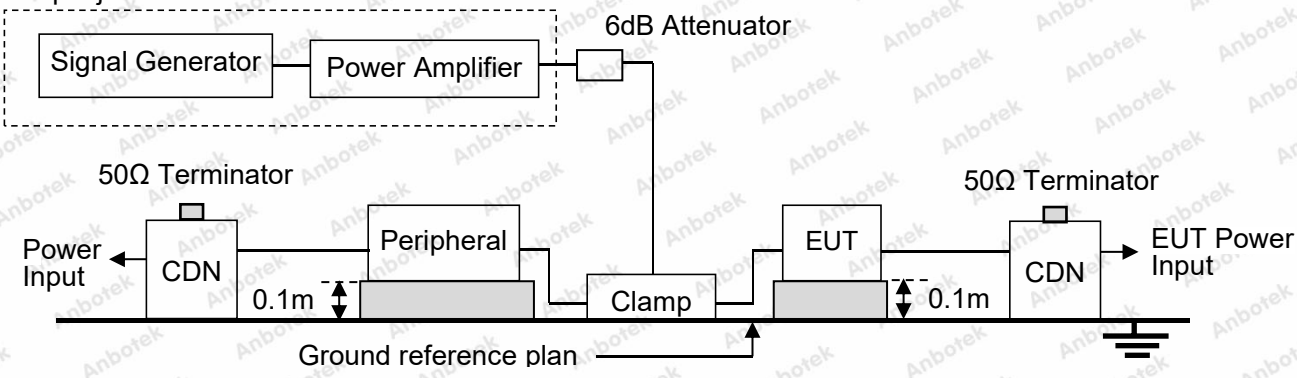
Level	Field Strength V
1.	1
2.	3
3.	10
X.	Special

10.2. Test Setup

CDN injection:



Clamp injection:



10.3. Test Procedure

a. The EUT and peripheral are placed on an insulating support of 0.1 m height above a ground reference plan. The distance between EUT and CDN is 0.1 m to 0.3 m. All cables exiting the EUT are supported at a height of at least 30 mm above the ground reference plan.

b. The frequency range is swept from 150 kHz to 80MHz, with the signal 80% amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. The frequency range is swept incrementally. The step size was 1% of fundamental from 0.15MHz to 80MHz.

c. The dwell time at each frequency isn't less than the time necessary for the EUT to be able to respond.

10.4. Test Results

PASS

Please refer to the following page.

Injected Currents Susceptibility Test Results

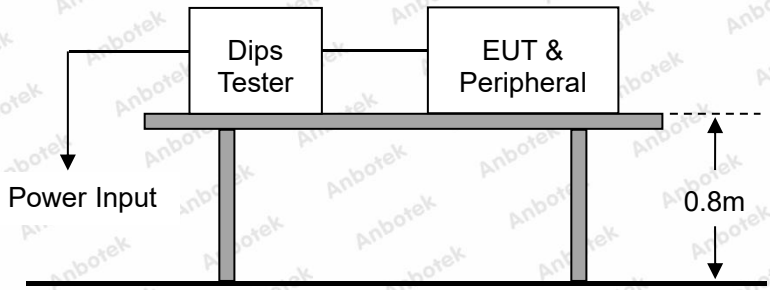
Test Result:	☒ Pass ☐ Fail	Temperature:	23.6℃
Power Supply:	AC 230V, 50Hz	Humidity:	56%
Frequency Range (MHz)	Injected Position	Strength (Un-modulated)	Result
0.15 ~ 80	AC Mains	10V	☒A ☐B ☐C
Remark : 1. Modulation Signal:1KHz 80% AM			

11. Voltage Dips and Interruptions Immunity Test

11.1. Test Specification

Test Standard:	EEN IEC 61800-3
Basic standard:	IEC 61000-4-11: 2020
Performance Criterion:	☐0%, 0.5 period, Criterion B
	☐70%, 25 periods for 50Hz, Criteria C
	☐0%, 250 periods for 50Hz, Criteria C
	☐70%, 30 periods for 60Hz, Criteria C
	☐0%, 300 periods for 60Hz, Criteria C

11.2. Test Setup



11.3. Test Procedure

a. Where the equipment has a rated voltage the following shall apply:
- If the voltage range does not exceed 20% of the lower voltage specified for the rated voltage range, a single voltage within that range may be specified as a basis for test level specification.
- In all other cases, the test procedure shall be applied for both the lowest and highest voltages declared in the voltage range.
b. Test Conditions
- Select operated voltage and frequency of EUT - Test of interval: 10 sec.
- Level and duration: Sequence of 3 dips/interrupts.
- Voltage rise (and fall) time: 1.5 μs.
c. Changes to occur at 0 degree crossover point of the voltage waveform.

11.4. Test Results

Not applicable.

APPENDIX I -- TEST SETUP PHOTOGRAPH

Photo of Power Line Conducted Emission Test

Photo of Radiated Emission Test (Below 1 GHz)

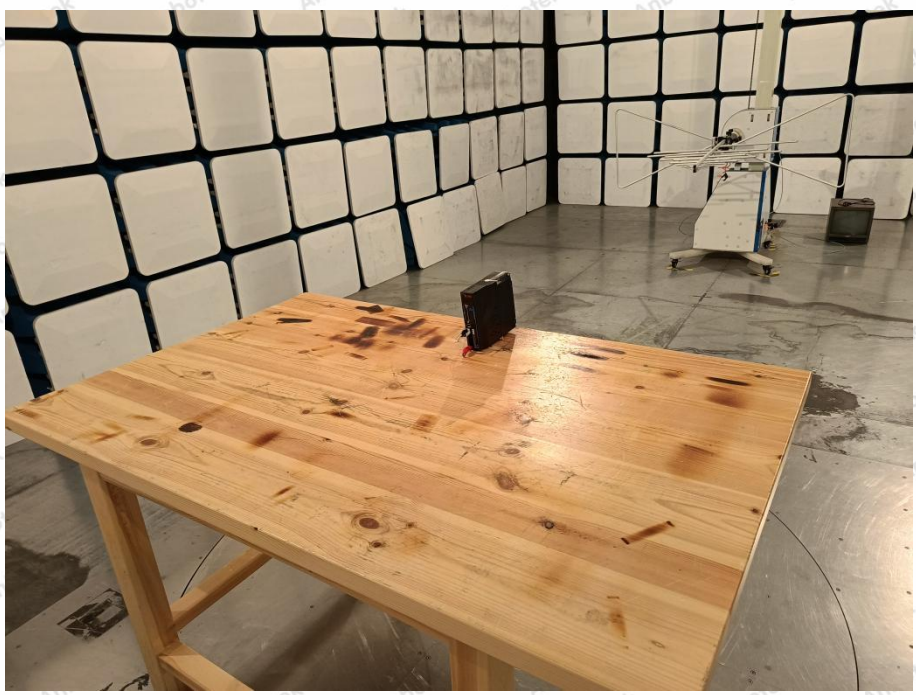


Photo of Harmonic Current And Flicker Test

Photo of Electrostatic Discharge Immunity Test

Photo of RF Field Strength Immunity Test

Photo of Electrical Fast Transient/Burst Immunity Test

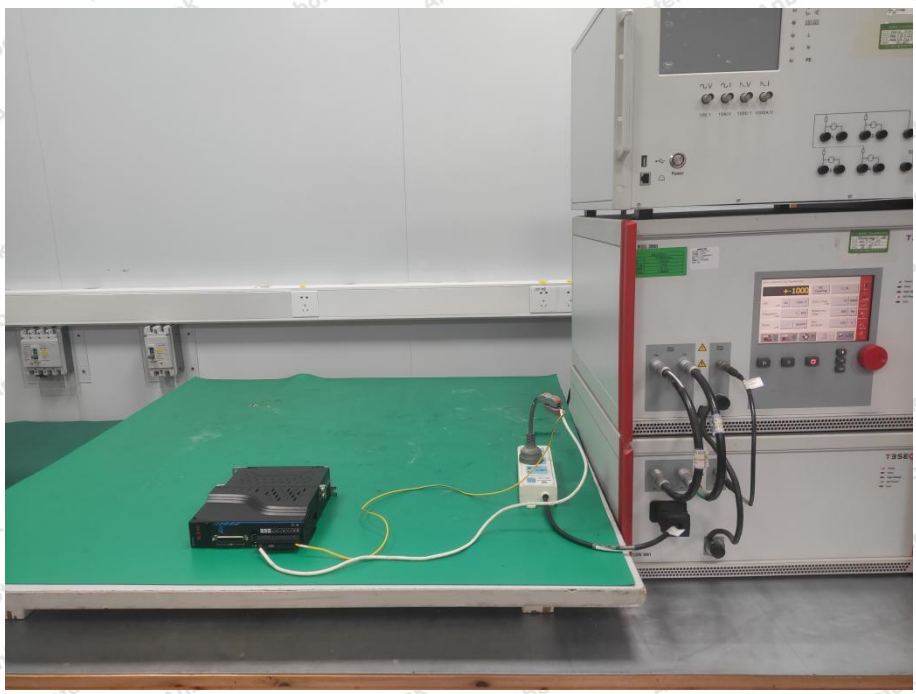
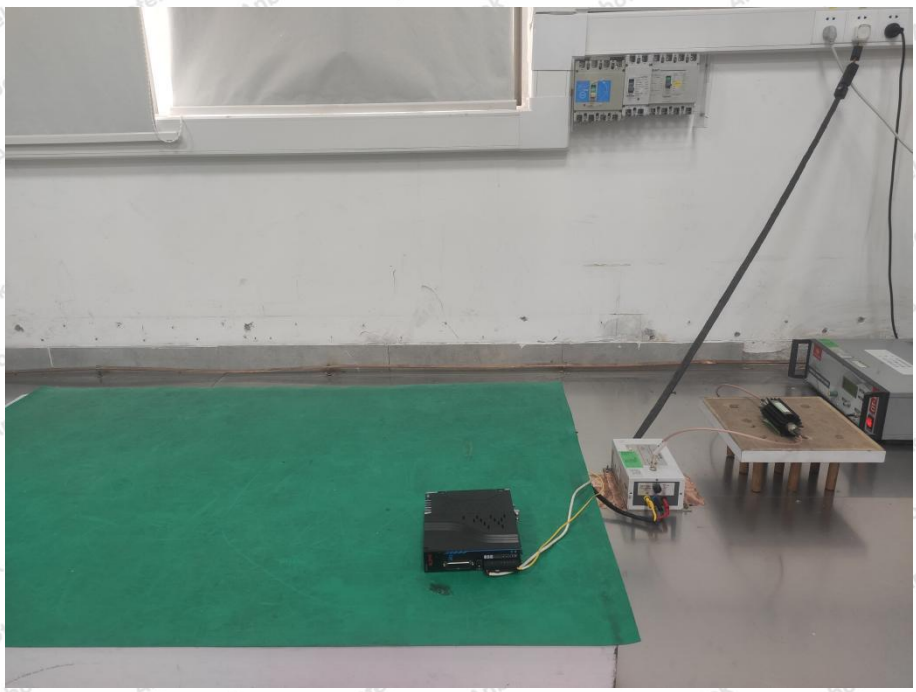


Photo of Surge Immunity Test

Photo of Injected Currents Susceptibility Test



APPENDIX II -- Photo documentation

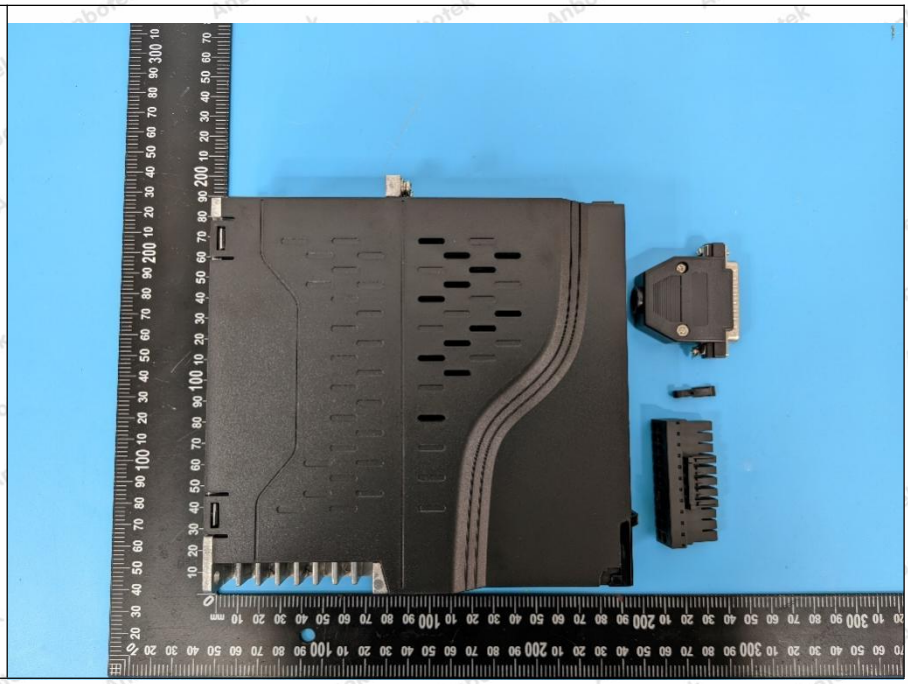
Photo 1 **All**	
Photo 2 **Side**	

Photo 3

Side

Photo 4

Side

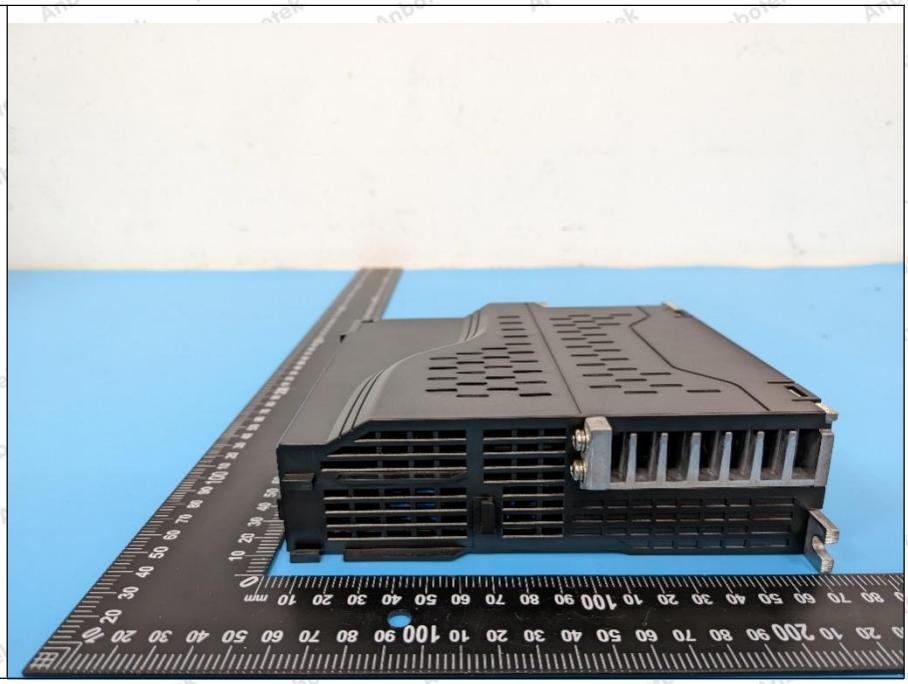


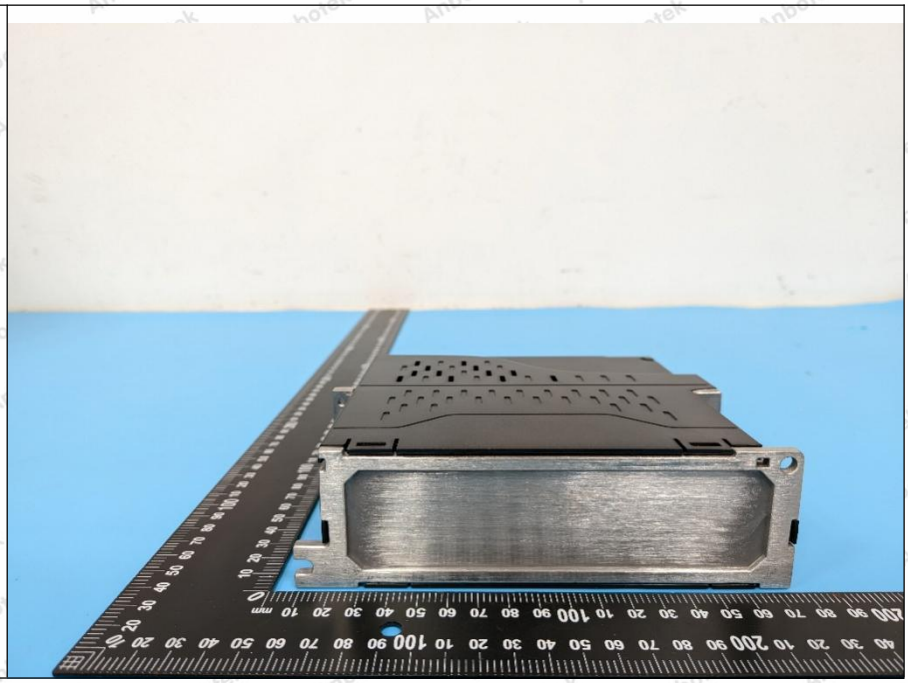
Photo 5 **Side**	

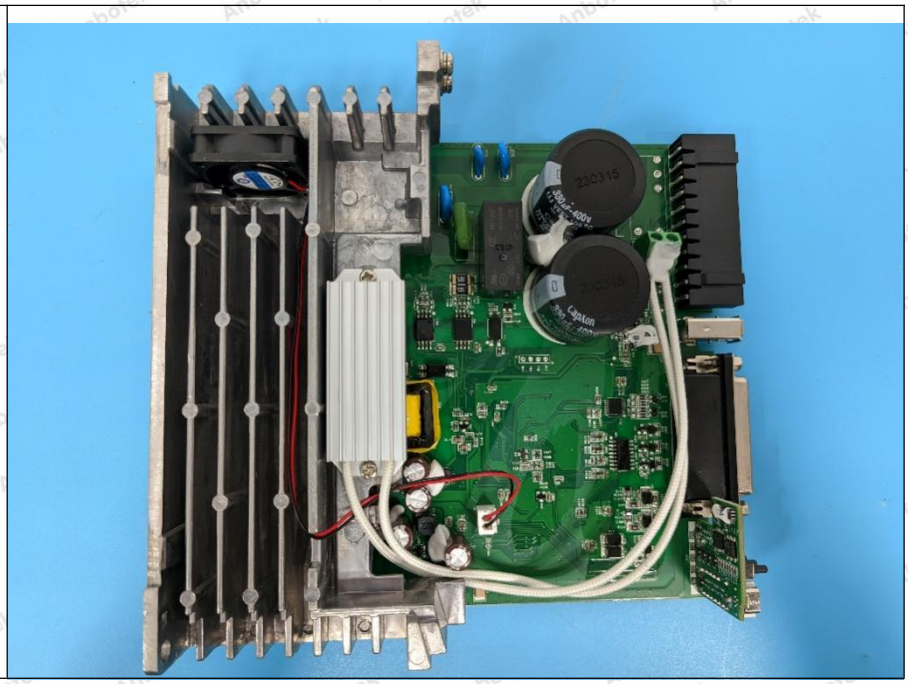
Photo 6 **Internal**	

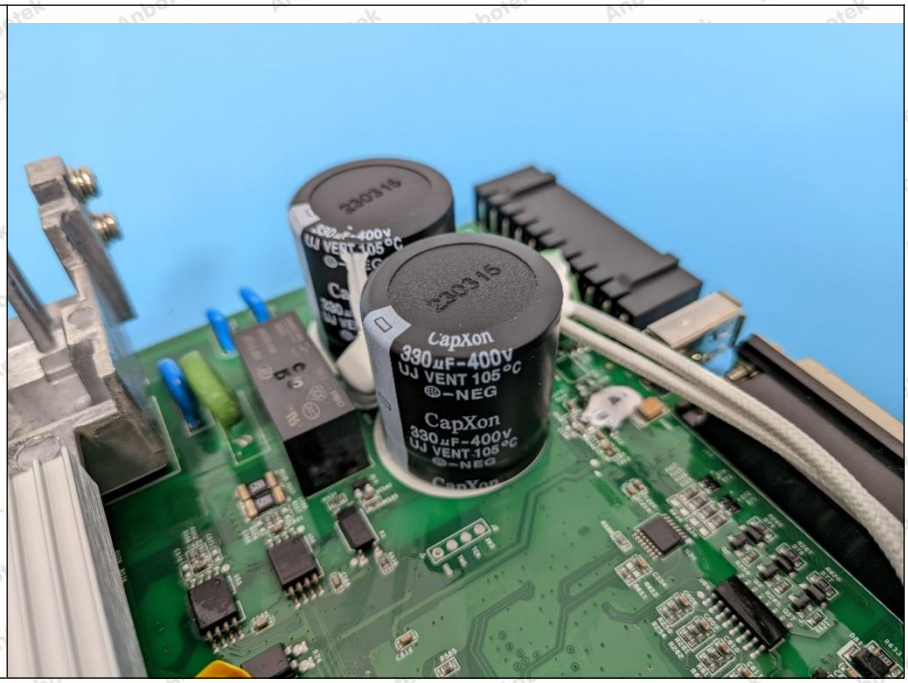
Photo 7 **Internal**	

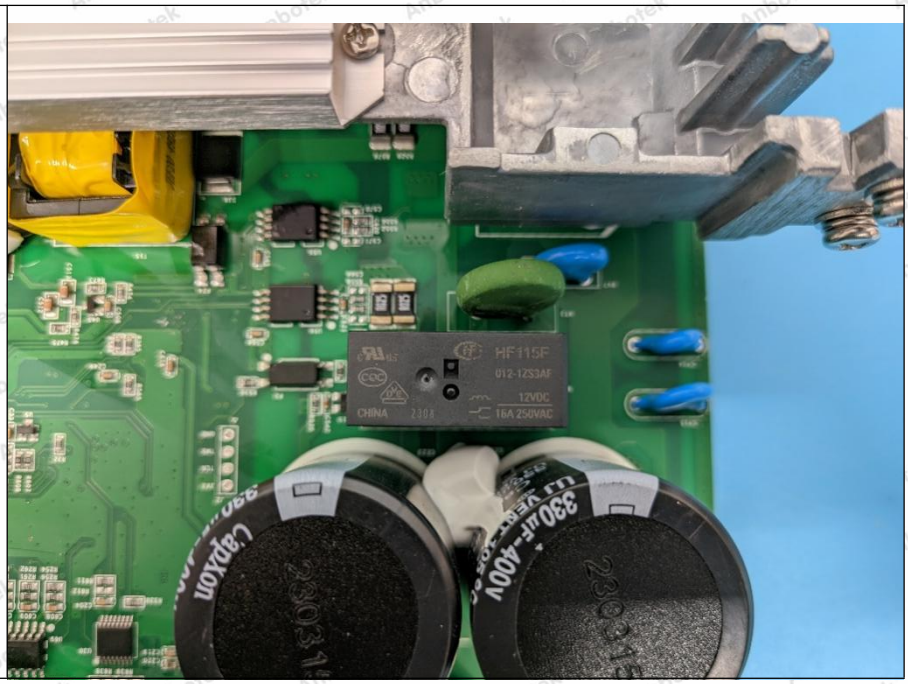
Photo 8 **Internal**	

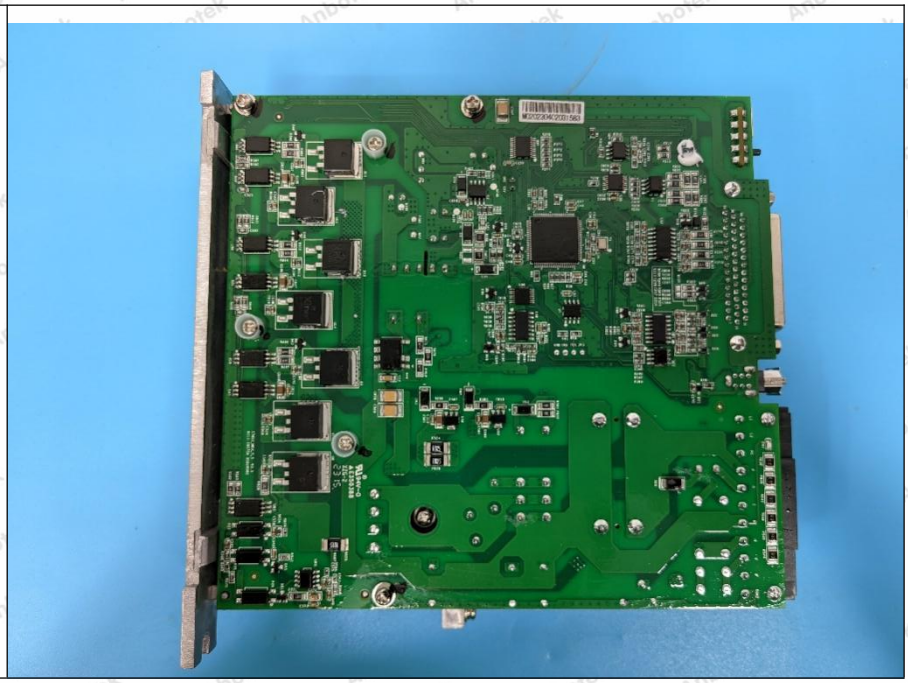
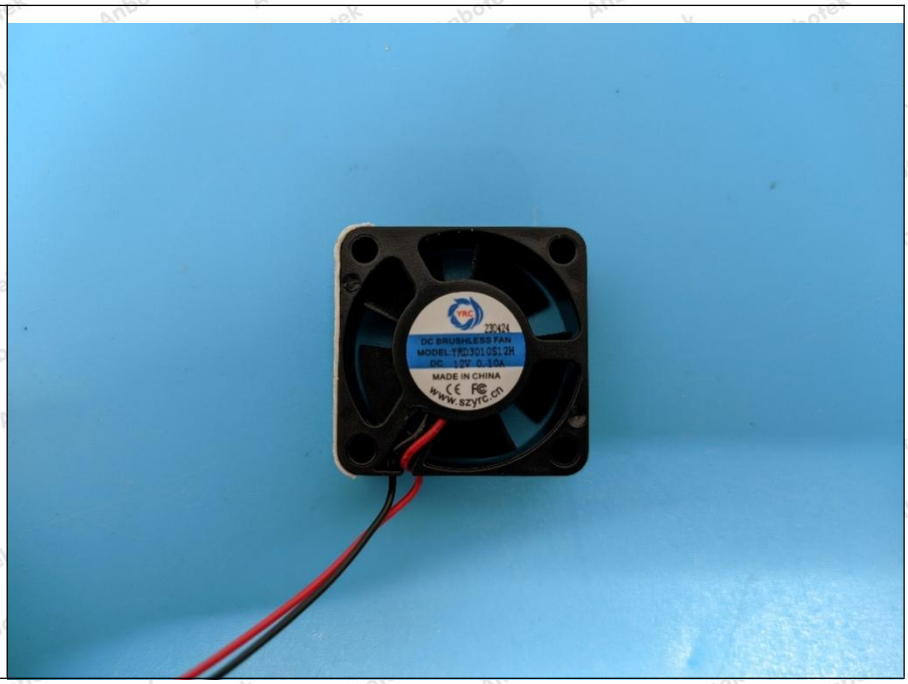
Photo 9 **Internal**	

Photo 10 **Internal**	

CE Label

1. The CE conformity marking must consist of the initials 'CE' taking the following form:

   If the CE marking is reduced or enlarged, the proportions given in the above graduated drawing must be respected.

2. The CE marking must have a height of at least 5 mm except where this is not possible on account of the nature of the apparatus.

3. The CE marking must be affixed to the product or to its data plate. Additionally it must be affixed to the packaging, if any, and to the accompanying documents.

4. The CE marking must be affixed visibly, legibly and indelibly.

   It must have the same height as the initials 'CE'.

---------- End of Report ----------